## **SPECIFICATIONS**

#### HIGH-FREQUENCY SMD CRYSTAL UNIT

Spec. No. X1E000391XXXX00

Type. FA3225AA

Frequency. 8 - 60 MHz

Date. 4<sup>th</sup> - June. 2013

Established : TD Production Engineering Department			
Approval	Checked	Responsible	
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## SPECIFICATIONS

Preliminary

#### 1. Application

This document is applicable to the crystal unit that are delivered from Seiko Epson Corp.

This product complies with RoHS Directive. Designed for automotive safety application.

This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes. Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

#### 2. Product No. / Model

X1E000391XXXX00 / FA3225AA.

#### 3. Packing

It is subject to the packing standard of Seiko Epson Corp.

#### 4. Warranty

Defective parts which originate with us are replaced free of charge in the case of defects being found with 12 months after delivery.

#### 5. Amendment and/or termination

Amendment and/or termination of this specification is subject to the agreement between the two parties.

#### 6. Contents

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# Preliminary

## [1] Absolute maximum ratings

1	1					
No.	Parameter	Rating value	Note			
1	Storage temperature	-55 °C to +155 °C	Suppose to be within CI std. at +25 °C $\pm$ 3 °C			

## [2] Operating range

			Value		
No.	Parameter	Symbol	Min.	Тур.	Max.
1	Operating temperature	Topr	-40 °C		+150 °C
2	Drive level	DL	10 μW		200 μW

## [3] Electrical characteristics

No.	Parameter	Symbol	Standard	Conditions
1	Nominal frequency	fo	8 - 60 MHz	Fundamental
2	Frequency tolerance	∆f/fo	$\pm$ 30 $ imes$ 10 <sup>-6</sup>	CL = 8pF to ∞ Ta = +25 °C±3 °C Drive level : 100 μW Not include aging
3	Series resistance (CI)	R1	Table. 1	π circuit IEC 60444-2 Drive level : 100 μW Ta= -40 °C to +125 °C
4	Shunt capacitance	Co	3.0 pF Max.	
5	Frequency Temperature Characteristics	Тор	Table. 2	(Ref. at +25 °C±3 °C) Drive level : 100 μW
6	Isolation resistance	IR	500 M $\Omega$ Min.	DC 100V $\times$ 60 sec. between each terminals
7	Aging	∆fa/f	$\pm$ 5 $ imes$ 10 <sup>-6</sup> /year	Ta = +25 °C±3 °C Drive level : 100 μW

Table.1Series resistance (CI)

Frequency	Series resistance
$8MHz \leq f < 9.8MHz$	500 ΩMax
$9.8MHz \leq f < 12MHz$	300 ΩMax
$12MHz \leq f < 13MHz$	120 ΩMax
$13$ MHz $\leq$ f < 20MHz	100 ΩMax
$20MHz \leq f \leq 60MHz$	80 ΩMax

Table.2 Frequency temperature characteristics

Temperature	Frequency tolerance
-40 °C ∼ +125 °C	±50.0 ×10-6 ~
-50 °C ∼ +150 °C	±150.0 ×10-6 ~

#### [4] Environmental and mechanical characteristics

Item No.3 to No.6 shall be tested after following pre conditioning.

Pre conditioning : Test crystal must be leaving in room temperature for 24h after reflow × 3.

(The company evaluation condition : We evaluate it by the following examination item and examination condition.)

Preliminary

		Value *1 *2	<b>T</b> ( <b>O</b> )	
NO.	Item	$\Delta f / f [1 \times 10^{-6}]$	l est Conditions	
1	Drop	(2) ± 10	100g dummy Jig (SEIKO EPSON	
			Standard) drop from 1500 mm height on	
			the Concrete 3 directions 10 times	
2	Vibration	(2) ± 5	10Hz to 55 Hz amplitude 0.75 mm	
			55Hz to 500Hz acceleration 98 m/s <sup>2</sup>	
			$10Hz \rightarrow 500Hz \rightarrow 10Hz \ 15min./cycle$	
			6 h (2 hours , 3 directions)	
3	High temperature storage	(1) ± 10	+125°C × 1 000 h	
4	Low temperature storage	(1) ± 5	-40°C × 1 000 h	
5	Temperature cycle	(1) ± 5 (8≤ f₀ ≤32MHz)	-40°C $\leftrightarrow$ +150°C 30 minutes at each	
		±10 (32< f₀≤60MHz)	temp. 100 cycle	
6	Temperature humidity	(1) ± 10	+85°C × 85%RH × 1 000 h	
	storage			
7	Resistance to soldering	± 5	For convention reflow soldering furnace	
	heat		(3 times)	
8	Substrate bending	No peeling-off at a	Bend width reaches 3 mm and hold for	
		soldered part	5 s ± 1 s × 1 time Ref. IEC 60068-2-21	
9	Shear	No peeling-off at a	10 N press for 10 s $\pm$ 1 s	
		soldered part	Ref. IEC 60068-2-21	
10	Pull – off	No peeling-off at a	10 N press for 10 s $\pm$ 1 s	
		soldered part	Ref. IEC 60068-2-21	
11	Solderability	Terminals must be 95%	Dip termination into solder bath at	
		covered	+235 ℃ ± 5 ℃ for 5 s	
1		with fresh solder.	(Using Rosin Flux)	

< Notes >

1. Item No.1 to No.10 resistance at before above tests should be less than  $\pm 20$  % or less than  $\pm 10 \Omega$ .

2. \*1 Each test done independently.

3. \*2 Measuring 2 h to 24 h later leaving in room temperature after each test.

(1) Measuring 24 h later leaving in room temperature after each test.

(2) Measuring 2 h later leaving in room temperature after each test.







[7] Notes

- 1. Max. three(3) timed reflow is allowed. Once miss soldering is happen, hand work soldering by soldering iron is recommended. (+350  $^{\circ}C \times within 5$  seconds)
- 2. Patterning should be followed by our recommended one.
- 3. Applying excessive excitation force to the crystal resonator may cause deterioration damage.
- 4. Unless adequate negative resistance is allocated in the oscillation circuit, start up time of oscillation may be increased, or no oscillation may occur. In order to avoid this, please provide enough negative resistance in the circuit design.

How to check the negative resistance



[-R]>CI × 10

(1) Connect the resister(R) to the circuit in series with the crystal

resonator.

(2) Adjust R so that oscillation can start (or stop).

(3) Measure R when oscillation just start (or stop) in above(2).

(4) Get the negative resistance-R=R+CI value.(5) Recommended -R

- 5. The shortest line patterning on board is recommendable. Too long line on board may cause of abnormal oscillation.
- 6. To avoid malfunction, no pattern under or near the X'tal is allowed.
- 7. This device must be stored at the normal temperature and humidity conditions before mounting on a board.
- Too much exciting shock or vibration may cause deterioration on damage. Depending on the condition such as a shock in assembly machinery, the products may be damaged. Please check your condition in advance to maintain shock level to be smallest.
- 9. This product can be subjected to ultrasonic cleaning. However, the oscillator may be affected depending on the conditions of the cleaning. Check conditions prior to use.
- 10. When used/stored under high humidity condition, there is potential problem with condensation. Please take precautions to prevent condensation.
- 11. Please refer to packing specification regarding how to storage the products in the pack.